

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
		Examiner Toan C. To	Art Unit 3616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,460,574	10-1995	Hobaugh, James M.	464/162
*	B	US-6,557,433	05-2003	Castellon, Melchor Daumal	74/492
*	C	US-6,755,746	06-2004	Barnley et al.	464/162
*	D	US-4,667,530	05-1987	Mettler et al.	74/493
*	E	US-5,226,853	07-1993	Courgeon, Jean-Claude	464/160
*	F	US-5,235,734	08-1993	DuRocher et al.	29/455.1
*	G	US-2006/0252559	11-2006	Yamada, Yasuhisa	464/167
*	H	US-2006/0181069	08-2006	Yamada, Yasuhisa	280/775
*	I	US-2006/0162989	07-2006	Yamada, Yasuhisa	180/444
*	J	US-2006/0156855	07-2006	Yukawa et al.	074/493
*	K	US-2006/0068924	03-2006	Yamada, Yasuhisa	464/167
*	L	US-2006/0060022	03-2006	Yamada, Yasuhisa	074/492
*	M	US-2005/0104354	05-2005	Yamada et al.	280/775

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.